

**Search Notes**

Application/Control No.

10/544,253

Examiner

HUYEN D. LE

Applicant(s)/Patent under  
Reexamination

OHBAYASHI ET AL.

Art Unit

2615

**SEARCHED**

Class	Subclass	Date	Examiner
381	113, 116, 174, 175, 190, 191	1/14/2008	HL
381	369	1/14/2008	HL
367	170	1/14/2008	HL
367	181	1/14/2008	HL
367	140	1/14/2008	HL
310	322	1/14/2008	HL
310	334	1/14/2008	HL

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
See East Search History		1/14/2008	HL

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR